

<b>Notice of References Cited</b>	Application/Control No. 10/697,884	Applicant(s)/Patent Under Reexamination KIM, WOO CHAN	
	Examiner BRIAN P. YENKE	Art Unit 2622	Page 1 of 1

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*	B	US-7,042,937	05-2006	Birru, Dagnachew	375/233
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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